Analytical and Imaging Solutions for Advanced R&D

SCANNING ELECTRON MICROSCOPES

Choose the Right SEM for Your Lab



Tabletop



W-SEM



Multipurpose FEG

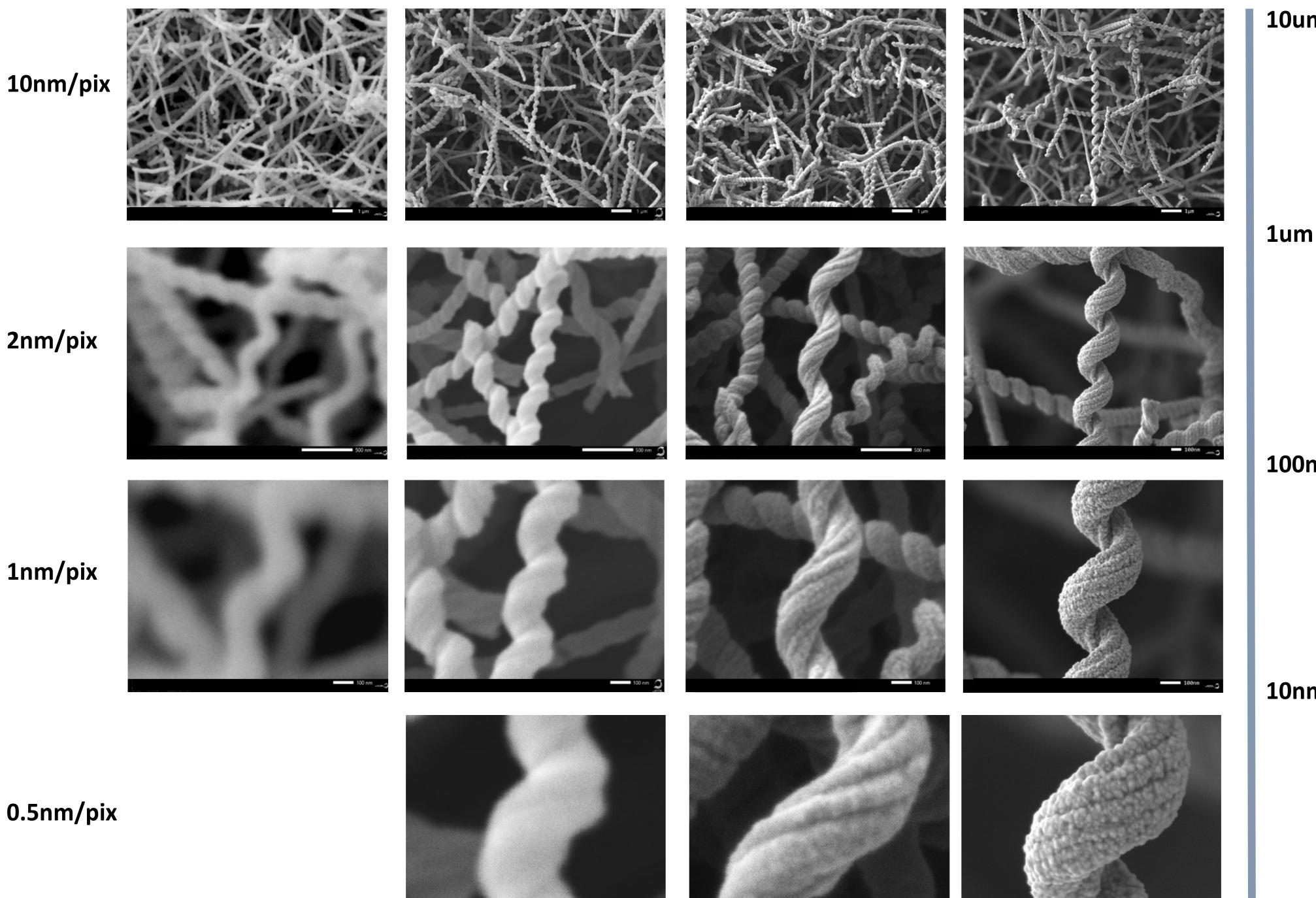


UHR FEG

10um



\$



100nm

10nm



\$\$\$

JEOL Intelligent SEM technology offers the best solutions for your imaging and analysis needs. All JEOL SEMs feature advanced electron optics combined with hardware and software algorithms to provide exceptional ease of use and streamlined workflow:

 Automated alignment, focusing and stigmation
Seamless navigation from optical to SEM image • Embedded chemical composition analysis • Multi-area automated acquisition (mosaic) • Unparallel service and applications support